

Examination of LM741 Operational Amplifier in High and Low Gain Configurations

by

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1 Introduction

Operational Amplifiers, often referred to as *op-amps*, are a vital part of data acquisition circuits and circuits that rely on threshold voltage inputs to activate additional components. As the name suggest, om-amps serve as voltage amplifiers and can be setup in various configurations using passive circuit elements such as resistors and capacitors. Figure 1 illustrates a LM741 op-amp in a negative feedback loop configuration.

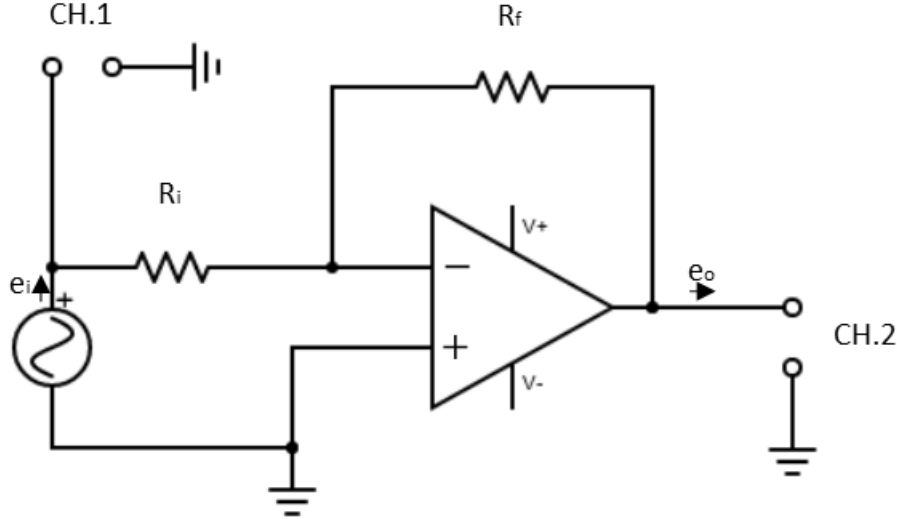


Figure 1: LM741 operation amplifier negative feedback loop schematic. All components of the circuit are grounded using a common ground. CH1 and CH2 represent probe connection on Vbench Interface.

1.1 Gain

In an open loop configuration, the output voltage of an op-amp quickly reaches saturation and may not provide useful results in many data acquisitions applications. A negative feedback loop, however, allows for greater control over amplification characteristics. Referred to as *gain*, the relationship between input and output voltages can be expressed as :

$$e_o = -Ge_i = -\frac{R_f}{R_i}e_i \quad (\text{Eq. 1})$$

G represents gain, and R_f and R_i correspond to resistors shown in Figure 1. The negative sign in Equation 1 is a consequence of the input voltage, e_i , feeding into the inverting channel on the op-amp, and e_o represents the expected output from the op-amp. Unlike passive circuit elements, op-amps need an external power source to operate. The power supply is shown to by the inputs V+ and V-.

1.2 First Order System

Developing a first order differential equation and making the assumption $R_f \gg R_i$ yields

$$\frac{\mu R_f}{AR_i} \frac{de_o}{dt} + e_o = -\frac{R_f}{R_i} e_i \quad (\text{Eq. 2})$$

where variables μ and A are properties of a given op-amp. Solving the first order ODE yields a complex solution, however, deriving a transfer function and taking the modulus produces a semi-analytical model :

$$|H|_{theo} = \frac{R_f/R_i}{\sqrt{1 + \omega^2 \left(\frac{\mu R_f}{A R_i}\right)^2}} \quad (\text{Eq. 3})$$

Since μ and A are experimentally derived quantities, the subscript *theo* denotes a semi-theoretical model, and the natural frequency can be rewritten in terms of frequency as $\omega = 2\pi f$. Furthermore, the modulus of the transfer function can also be written in terms of input and output voltage as

$$|H|_{exp} = \frac{e_o}{e_i} \quad (\text{Eq. 4})$$

where the subscript *exp* refers to a model that is exclusively dependent on variables measured during the experiment.

1.3 Cutoff Frequency and Gain Bandwidth Product

In a negative feedback loop, the relationship between $|H|$ vs f can be broken categorized into three distinct regions :

$$\begin{aligned} 2\pi f \frac{\mu R_f}{AR_i} &<< 1 \Rightarrow |H| = G \\ 2\pi f \frac{\mu R_f}{AR_i} &\gg 1 \Rightarrow |H| = 1 \\ 2\pi f \frac{\mu R_f}{AR_i} &= 1 \Rightarrow |H| = \frac{G}{\sqrt{2}} \end{aligned}$$

The latter of the regions represents a particularly interesting relationship known as a circuit's cutoff frequency. Explicitly defined by relationship,

$$f_0 = \frac{AR_i}{2\pi\mu R_f} \quad (\text{Eq. 5})$$

the cutoff frequency, f_0 , is the frequency at which the circuit can no longer amplify the input voltage and thus, begins to attenuate the signal. In addition to identifying the range of frequencies for max gain given a set of resistors in a circuit, the cutoff frequency is also important for defining an op-amp's Gain Bandwidth Product (GBP). Represented by the

variable f^* in Equation 6, GBP is strictly a property a property of the op-amp in the circuit that governs the inverse relationship between gain and cutoff frequency (i.e., as gain increase, cutoff frequency decrease and vice versa).

$$f^* = f_0 G \quad (\text{Eq. 6})$$

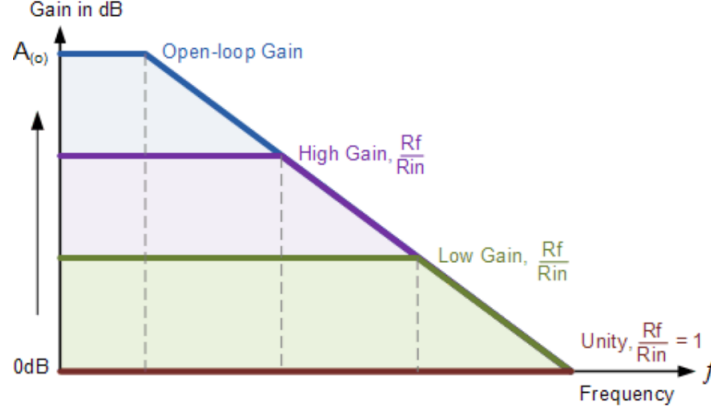


Figure 2: The relationship between cutoff frequency (vertical dashed lines) and gain (horizontal lines), for a given op-amp. Lowering the gain of a circuit allows for a greater frequency range. Image courtesy of *electronics-tutorials.ws*

2 Procedures

2.1 Materials and Experiment Setup

By using a National Instruments VirtualBench VB-8012 to take measurements and control input signals, and setting up a negative feedback loop as shown in Figure 1, the LM741 op-amp was characterized using frequencies ranging from 100Hz to 1MHz and two different gains. The input resistors were selected based on nominal values of $2\text{k}\Omega$ and $20\text{k}\Omega$ for setups 1 and 2, respectively. The feedback resistor was selected based on a nominal value of $200\text{k}\Omega$ and was kept throughout the entire experiment. All resistors were measured before being integrated into the circuit. Channel 1 and channel 2 were setup to measure input and output voltages, and all grounds were connected to a common ground. Both experimental setups were based on the schematic shown in Figure 1 and followed identical procedures.

2.2 Methods

Beginning with a frequency of 100Hz, the experimental gain was calculated by taking ratio between measured values of output and input voltages. According the semi-theoretical

model, the ratio between output and input voltage should be equal to ratio between feedback and input resistors. This served as the initial benchmark for comparing the experimental and semi-theoretical models.

Since it was known that the relationship between gain and frequency is non-linear near the cutoff frequency, input and output voltage measurements were concentrated in this region. Initial guesses for the cutoff frequency were determined by estimating what the output voltage would need to be to satisfy the requirement $e_o/e_i = G/\sqrt{2}$. Since e_i was relatively constant, the frequency was adjusted in a series of trial and error modifications until e_o was measurement within the appropriate value. Once the cutoff frequency was determined within reasonable experimental expectation, input and output voltages were measured, used to calculate $|H|$ using Equation 4, and plotted until on a log-log scale until the non-linear region of the $|H|$ vs f graph was well characterized. Afterwards, the linear regions were characterized by taking a enough data to adequately represent the system response to relatively high and low frequencies.

3 Results

Gain as a function of input signal frequency for the low gain negative feedback circuit is plotted in Figure 3. Additionally, the semi-theoretical model expressed in Equation 3 is also plotted for comparison between actual and anticipated results.

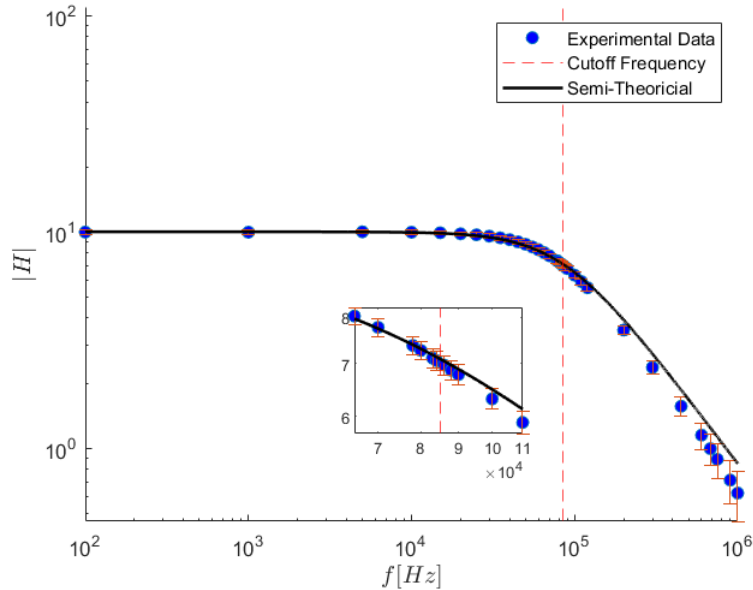


Figure 3: Op-amp in a low gain configuration

It is clear that semi-theoretical and experimental models expressed in Equations 3 and 4 are in agreement until the system approaches the cutoff frequency. Beyond the cutoff

frequency, however, the two models begin to diverge and the experimental data shows a lower than anticipated gain.

Figure 4 shows gain versus input frequency data for the high gain negative feedback circuit. In this configuration, the experimental and semi-theoretical models agree through the entire domain of frequencies tested.

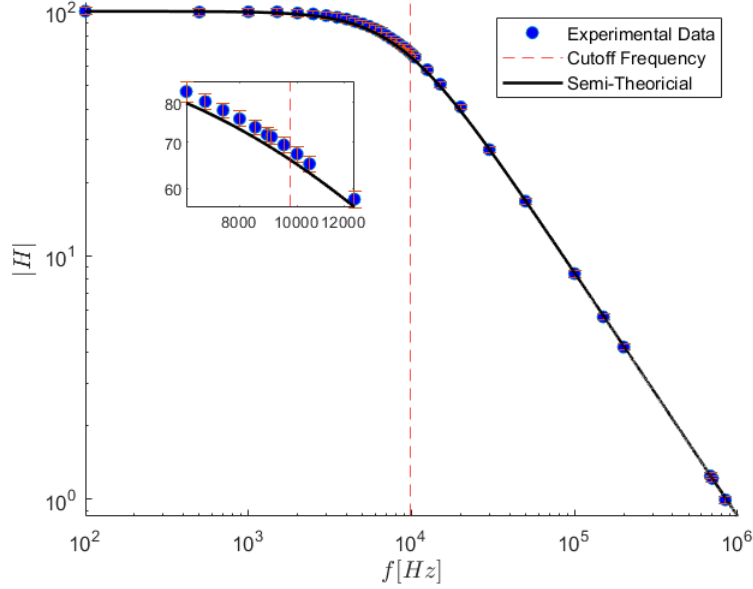


Figure 4: Op-amp in a high gain configuration

As anticipated, the cutoff frequency was significantly reduced as a consequence of the greater amount of gain generated. Both experimental sets of data support also the GBD as a property of the op-amp rather than other circuit elements. Regardless of the resistors chosen to create the circuit, both high and low gain configurations converged towards the same GBD. Thus, both circuits have a unique usable range for amplification that matches ideal gain expressed in Equation 1. In either case, the usable range can be defined by the relationship $f \ll f_0$, that is the horizontal regions in Figures 3 and 4.

3.1 Experimental Error

To conclude whether experimental and theoretical gain are equivalent, the associated error of each quantity must be taken into account. Furthermore, since experimental gain changes as the system approaches cutoff frequency the analysis shall be performed using a low frequency data point (i.e., 100Hz). Equations 7 and 8 represent the relative uncertainties for experimental and theoretical gain.

$$\Delta G_{exp} = G_{exp} \sqrt{\left(\frac{\Delta e_i}{e_i}\right)^2 + \left(\frac{\Delta e_0}{e_0}\right)^2} \quad (\text{Eq. 7})$$

$$\Delta G_{theo} = G_{theo} \sqrt{\left(\frac{\Delta R_i}{R_i}\right)^2 + \left(\frac{\Delta R_0}{R_0}\right)^2} \quad (\text{Eq. 8})$$

Since the cutoff frequency in each setup consisted of scanning through various frequencies until the amplification fell within the appropriate window, the cutoff frequency and its relative uncertainty can be expressed using the following set of equations,

$$\begin{aligned} f_0 &= \frac{f_{high} + f_{low}}{2} \\ \Delta f_0 &= \frac{f_{high} - f_{low}}{2} \end{aligned} \quad (\text{Eq. 9})$$

where the subscripts *high* and *low* denote the two frequencies used to fulfill the amplification requirement.

Table 1 summarizes key values, as well as relative uncertainties. It is shown that $G_{exp} \pm \Delta G_{exp} = G_{theo} \pm \Delta G_{theo}$ in both low and high gain configurations.

Key Values							
R_f	196960	ΔR_f	1970	$e_{i,1}$.097	$\Delta e_{i,1}$.002
$R_{i,1}$	19649	$\Delta R_{i,1}$	197	$e_{o,1}$.973	$\Delta e_{o,1}$.016
$R_{i,2}$	1958	$\Delta R_{i,2}$	20	$e_{i,2}$.068	$\Delta e_{i,2}$.002
$f_{0,1}$	85000	$\Delta f_{0,1}$	1000	$e_{o,2}$	6.88	$\Delta e_{o,2}$.156
$f_{0,2}$	9750	$\Delta f_{0,2}$	250	f^*	$9.8 * 10^5$	Δf^*	28720
$G_{exp,1}$	10	$\Delta G_{exp,1}$.2	$G_{theo,1}$	10	$\Delta G_{theo,1}$.1
$G_{exp,2}$	101	$\Delta G_{exp,2}$	3.2	$G_{theo,2}$	101	$\Delta G_{theo,2}$	1.4

Table 1: Subscripts 1 and 2 denote experiment setups 1 and 2. Additionally, the subscripts i,o, and f denote input, output and feedback, respectively. For convenience, the uncertainty of each resistor was taken to be $\pm 1\%$.

A MATLAB Script

```
1 clear;clc;close all
2 format long
3 %% Import and Label Data for each setup
4 Ri1 = 19649;
5 Rf1 = 196960;
6 G1 = Rf1/Ri1;
7 dG1 = G1 * sqrt( (Rf1*.01/Rf1)^2 + (Ri1*.01/Ri1)^2 );
8 dataSetup1 = xlsread('RawData.xlsx','Setup1');
9 f1 = dataSetup1(:,1);
10 ch1vdiv1 = dataSetup1(:,2);
11 dei1 = dataSetup1(:,3);
12 ei1 = dataSetup1(:,4)/1000;
13 ch2vdiv1 = dataSetup1(:,5);
14 deo1 = dataSetup1(:,6);
15 eo1 = dataSetup1(:,7)/1000;
16 H1 = dataSetup1(:,8);
17 dH1 = H1 .* sqrt( (deo1./eo1).^2 + (dei1./ei1).^2 );
18
19 Ri2 = 1958;
20 Rf2 = 196960;
21 G2 = Rf2/Ri2;
22 dG2 = G2 * sqrt( (Rf2*.01/Rf2)^2 + (Ri2*.01/Ri2)^2 );
23 dataSetup2 = xlsread('RawData.xlsx','Setup2');
24 f2 = dataSetup2(:,1);
25 ch1vdiv2 = dataSetup2(:,2);
26 dei2 = dataSetup2(:,3);
27 ei2 = dataSetup2(:,4);
28 ch2vdiv2 = dataSetup2(:,5);
29 deo2 = dataSetup2(:,6);
30 eo2 = dataSetup2(:,7);
31 H2 = dataSetup2(:,8);
32 dH2 = H2 .* sqrt( (deo2./eo2).^2 + (dei2./ei2).^2 );
33
34 %% Determine Cutoff Frequency and Uncertainty
35 i = 1;
36 while H1(i) >= G1*.707
37     i=i+1;
38 end
39 f01 = .5 * ( f1(i) + f1(i+1) );
40 df01 = .5 * abs( f1(i) - f1(i+1) );
41 f1_sub = f1(i-5:i+5);
42 H1_sub = H1(i-5:i+5);
```



```

43 dH1_sub = dH1( i-5:i+5);
44
45
46 i = 1;
47 while H2(i) >= G2*.707
48     i=i+1;
49 end
50 f02 = .5 * ( f2(i) + f2(i+1) );
51 df02 = .5 * abs( f2(i) - f2(i+1) );
52 f2_sub = f2(i-7:i+3);
53 H2_sub = H2( i-7:i+3);
54 dH2_sub = dH2( i-7:i+3);
55
56 %% Build Analytical Model.
57 % k represents the constant associated with the Op-Amp A/(2*pi*
    mu)
58 k1 = f01*G1;
59 k2 = f02*G2;
60 dk1 = k1 * sqrt( (df01/f01)^2 + (dG1/G1)^2 );
61 dk2 = k2 * sqrt( (df02/f02)^2 + (dG2/G2)^2 );
62 f_theo = [100:100:1000000]';
63 H_theo1 = G1 ./ sqrt( 1 + (f_theo/k1*G1).^2 );
64 H_theo2 = G2 ./ sqrt( 1 + (f_theo/k1*G2).^2 );
65
66 %% Plot
67 % ===== Low Gain Plot =====
68 figure(1)
69 set(gca,'xscale','log','yscale','log','defaulttextinterpreter',
    'Latex')
70 ylim([0 110])
71 hold on
72 pls = scatter(f1,H1,'o','MarkerFaceColor','b');
73 errorbar(f1,H1,dH1,'vertical','LineStyle','none')
74 p1p = plot(f_theo,H_theo1,'k','LineWidth',1.5);
75 cutofff1 = xline(f01,'--r');
76 xlabel('$f[Hz]$', 'FontSize',12)
77 ylabel('$|H|$', 'FontSize',12)
78 legend([pls cutofff1 p1p],{'Experimental Data','Cutoff Frequency
    ','Semi-Theoretical'})
79 % ----- Minor-Plot for Figure 1 -----
80 ax1 = axes('Position',[.45 .25 .2 .2]);
81 box on;hold on
82 set(gca,'xscale','log','yscale','log','defaulttextinterpreter',
    'Latex')
83 plot(f1_sub,H1_sub,'o','MarkerSize',6,'MarkerFaceColor','b')

```

```

84 errorbar(f1_sub,H1_sub,dH1_sub,'vertical','LineStyle','none')
85 xline(f01,'--r');
86 plot(f_theo,H_theo1,'k','LineWidth',1.5);
87 xlabel('', 'FontSize',10,'Interpreter','latex')
88 ylabel('', 'FontSize',10,'Interpreter','latex')
89 xlim([f1_sub(1) f1_sub(end)])
90
91 % ===== High Gain Plot =====
92 figure(2)
93 set(gca,'xscale','log','yscale','log','defaulttextinterpreter',
    'Latex')
94 ylim([0 110])
95 hold on
96 p2s = scatter(f2,H2,'o','MarkerFaceColor','b');
97 errorbar(f2,H2,dH2,'vertical','LineStyle','none')
98 p2p = plot(f_theo,H_theo2,'k','LineWidth',1.5);
99 cutofff2 = xline(f02,'--r');
100 xlabel('$f[Hz]$', 'FontSize',12)
101 ylabel('$|H|$', 'FontSize',12)
102 legend([p2s cutofff2 p2p],{'Experimental Data','Cutoff Frequency',
    'Semi-Theoretical'})
103 % ----- Minor-Plot for Figure 2 -----
104 ax2 = axes('Position',[.25 .6 .2 .2]);
105 box on;hold on
106 set(gca,'xscale','log','yscale','log','defaulttextinterpreter',
    'Latex')
107 plot(f2_sub,H2_sub,'o','MarkerSize',6,'MarkerFaceColor','b')
108 errorbar(f2_sub,H2_sub,dH2_sub,'vertical','LineStyle','none')
109 plot(f_theo,H_theo2,'k','LineWidth',1.5)
110 xline(f02,'--r');
111 xlabel('', 'FontSize',10,'Interpreter','latex')
112 ylabel('', 'FontSize',10,'Interpreter','latex')
113 xlim([f2_sub(1) f2_sub(end)])

```